



March 1998

## DM74S03

### Quad 2-Input NAND Gates with Open-Collector Outputs

#### General Description

This device contains four independent gates each of which performs the logic NAND function. The open-collector outputs require external pull-up resistors for proper logical operation.

#### Pull-Up Resistor Equations

$$R_{MAX} = \frac{V_{CC}(\text{Min}) - V_{OH}}{N_1(I_{OH}) + N_2(I_{IH})}$$

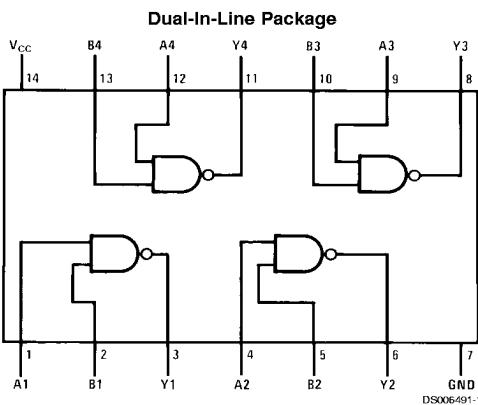
$$R_{MIN} = \frac{V_{CC}(\text{Max}) - V_{OL}}{I_{OL} - N_3(I_{IL})}$$

Where:  $N_1(I_{OH})$  = total maximum output high current for all outputs tied to pull-up resistor

$N_2(I_{IH})$  = total maximum input high current for all inputs tied to pull-up resistor

$N_3(I_{IL})$  = total maximum input low current for all inputs tied to pull-up resistor

#### Connection Diagram



#### Function Table

$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = High Logic Level

L = Low Logic Level

### Absolute Maximum Ratings (Note 1)

Supply Voltage	7V	Operating Free Air Temperature Range DM74S	0°C to +70°C
Input Voltage	5.5V	Storage Temperature Range	-65°C to +150°C
Output Voltage	7V		

### Recommended Operating Conditions

Symbol	Parameter	DM74S03			Units
		Min	Nom	Max	
$V_{CC}$	Supply Voltage	4.75	5	5.25	V
$V_{IH}$	High Level Input Voltage	2			V
$V_{IL}$	Low Level Input Voltage			0.8	V
$V_{OH}$	High Level Output Voltage			5.5	V
$I_{OL}$	Low Level Output Current			20	mA
$T_A$	Free Air Operating Temperature	0		70	°C

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

### Electrical Characteristics

over recommended operating free air temperature (unless otherwise noted)

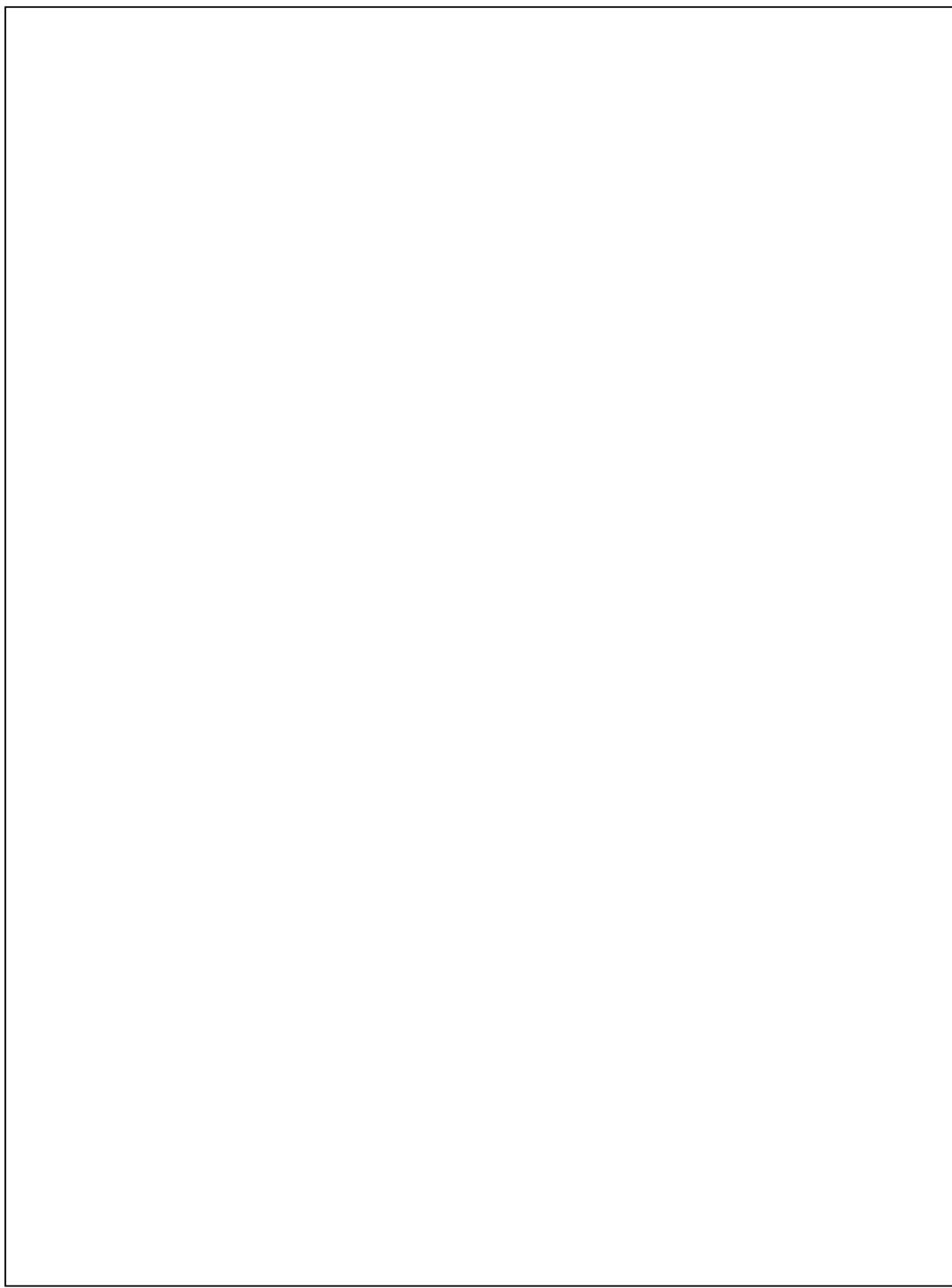
Symbol	Parameter	Conditions	Min	Typ (Note 2)	Max	Units
$V_I$	Input Clamp Voltage	$V_{CC} = \text{Min}$ , $I_I = -18 \text{ mA}$			-1.2	V
$I_{CEX}$	High Level Output Current	$V_{CC} = \text{Min}$ , $V_O = 5.5V$ $V_{IL} = \text{Max}$			250	μA
$V_{OL}$	Low Level Output Voltage	$V_{CC} = \text{Min}$ , $I_{OL} = \text{Max}$ $V_{IH} = \text{Min}$			0.5	V
$I_I$	Input Current @ Max Input Voltage	$V_{CC} = \text{Max}$ , $V_I = 5.5V$			1	mA
$I_{IH}$	High Level Input Current	$V_{CC} = \text{Max}$ , $V_I = 2.7V$			50	μA
$I_{IL}$	Low Level Input Current	$V_{CC} = \text{Max}$ , $V_I = 0.5V$			-2	mA
$I_{CCH}$	Supply Current with Outputs High	$V_{CC} = \text{Max}$		6.0	13.2	mA
$I_{CCL}$	Supply Current with Outputs Low	$V_{CC} = \text{Max}$	20		36	mA

### Switching Characteristics

at  $V_{CC} = 5V$  and  $T_A = 25^\circ\text{C}$

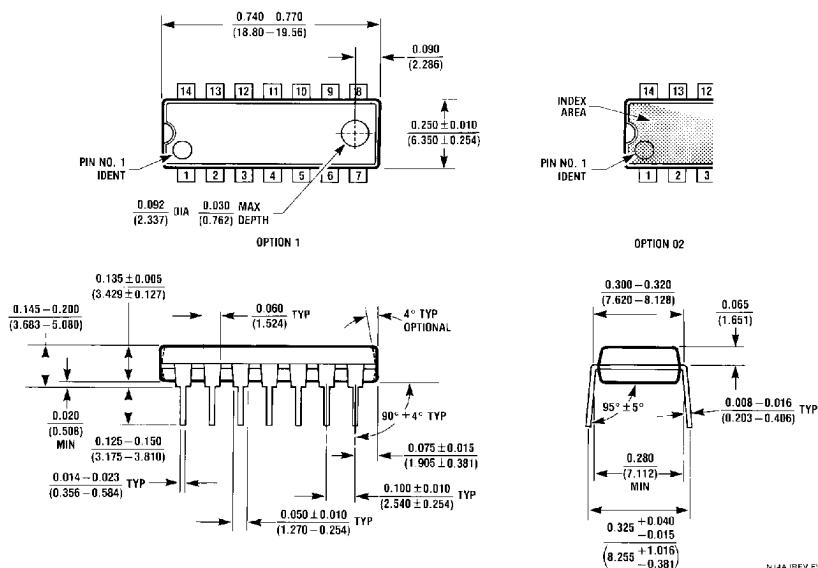
Symbol	Parameter	$R_L = 280\Omega$				Units	
		$C_L = 15 \text{ pF}$		$C_L = 50 \text{ pF}$			
		Min	Max	Min	Max		
$t_{PLH}$	Propagation Delay Time Low to High Level Output	2	7.5	3	11	ns	
$t_{PHL}$	Propagation Delay Time High to Low Level Output	2	7	3	11	ns	

Note 2: All typicals are at  $V_{CC} = 5V$ ,  $T_A = 25^\circ\text{C}$ .



## DM74S03 Quad 2-Input NAND Gates with Open-Collector Outputs

### Physical Dimensions inches (millimeters) unless otherwise noted



**14-Lead Molded Dual-In-Line Package (N)  
Order Number DM74S03N  
Package Number N14A**

N14A (REV F)

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